


<b>Search Notes</b> 	<b>Application/Control No.</b> 10781910	<b>Applicant(s)/Patent Under Reexamination</b> PEYRUCAIN ET AL.
	<b>Examiner</b> BENJAMIN P LEE	<b>Art Unit</b> 3641

SEARCHED			
Class	Subclass	Date	Examiner
244	185	1/27/2008	LEE
244	186	1/27/2008	LEE
244	187	1/27/2008	LEE
244	195	1/27/2008	LEE

SEARCH NOTES		
Search Notes	Date	Examiner
updated search	1/27/2008	LEE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner